Page 1 of 9

1 Photo

1.1 Test Setup Photo

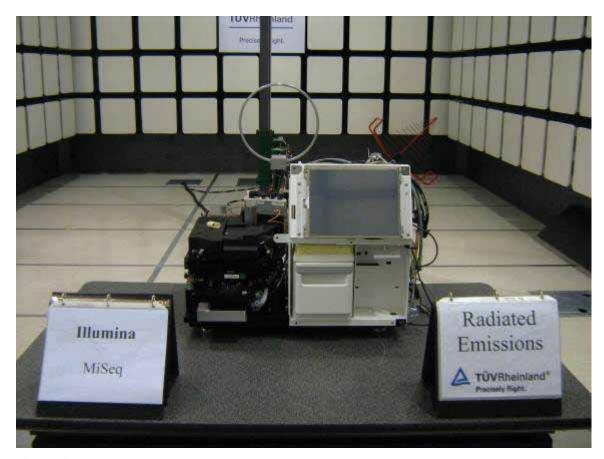


Figure 1: Test Setup for 9 kHz to 30MHz (Front View) – Loop Facing EUT

Report Number: 31161819.002

EUT: MiSeq System Model: MiSeq System

Page 2 of 9



Figure 2: Test Setup for 9 kHz to 30MHz (Rear View) – Loop Facing Away

Report Number: 31161819.002

EUT: MiSeq System Model: MiSeq System

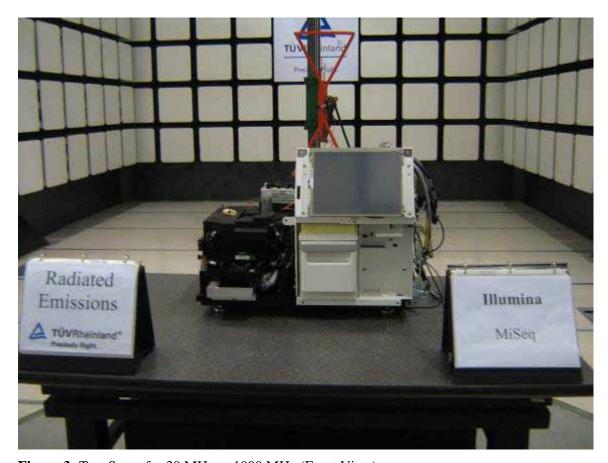


Figure 3: Test Setup for 30 MHz to 1000 MHz (Front View)

Report Number: 31161819.002 Page 3 of 9

EUT: MiSeq System Model: MiSeq System

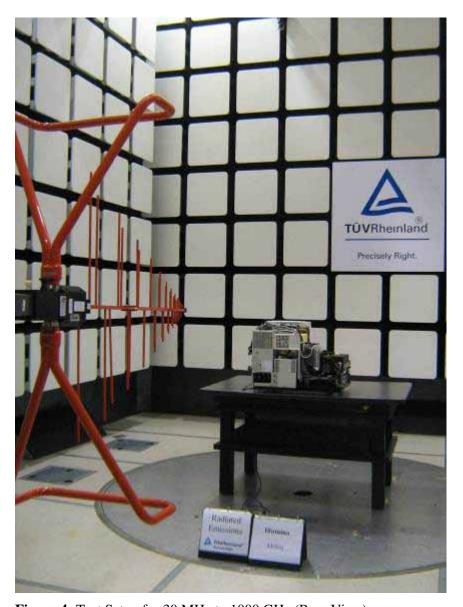


Figure 4: Test Setup for 30 MHz to 1000 GHz (Rear View)

Report Number: 31161819.002

EUT: MiSeq System Model: MiSeq System

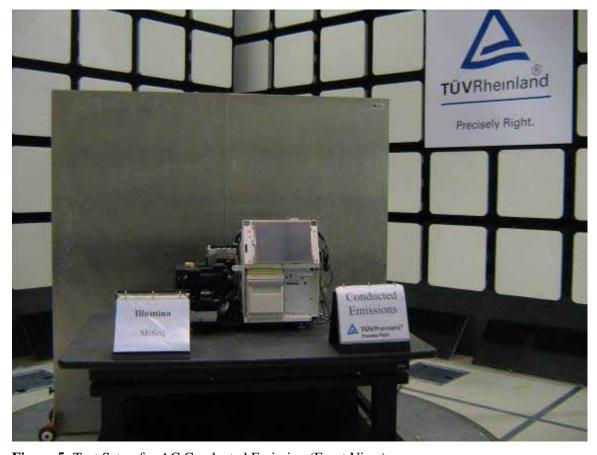


Figure 5: Test Setup for AC Conducted Emission (Front View)

Report Number: 31161819.002 Page 5 of 9

EUT: MiSeq System Model: MiSeq System

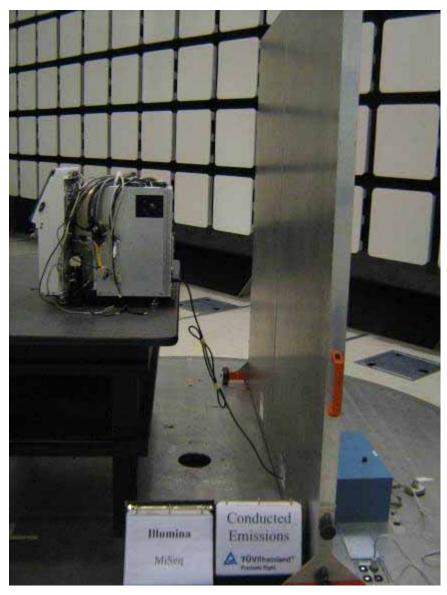


Figure 6: Test Setup for AC Conducted Emission (Side View)

Report Number: 31161819.002

EUT: MiSeq System Model: MiSeq System



Figure 7: Frequency Stability Test Setup (Outside Thermal)

Report Number: 31161819.002 Page 7 of 9

EUT: MiSeq System Model: MiSeq System

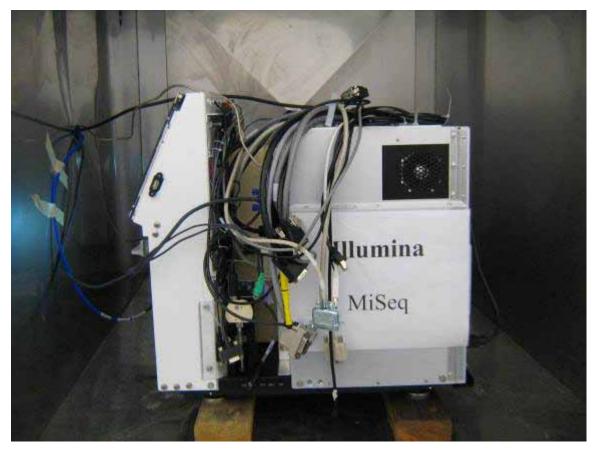


Figure 8: Frequency Stability Test Setup (Inside Thermal Chamber)

Report Number: 31161819.002 Page 8 of 9

EUT: MiSeq System Model: MiSeq System

Page 9 of 9

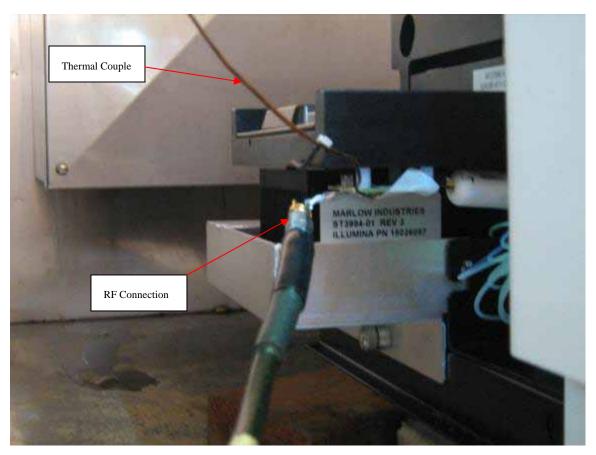


Figure 9: Frequency Stability Test Setup (RF Connection to RFID)

Report Number: 31161819.002

EUT: MiSeq System Model: MiSeq System